Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/074,759	NOERPEL ET AL.	
Examiner	Art Unit	
Julio R. Perez	2681	

SEARCHED				
Class	Subclass	Date	Examiner	
455	434	12/7/2004	JР	
370	316	12/7/2004	JP	
	337	12/7/2004	JP	
	338	12/7/2004	JP	
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INTERFERENCE SEARCHED				
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SEAR((INCLUDING SE	CH NOTES EARCH STRATEGY)
	DATE	EXMR
East	12/7/2004	JP
Nick	5/31/2005	JP
Willington Chin	6/13/2005	JP
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